

N-Channel 200-V (D-S) MOSFET

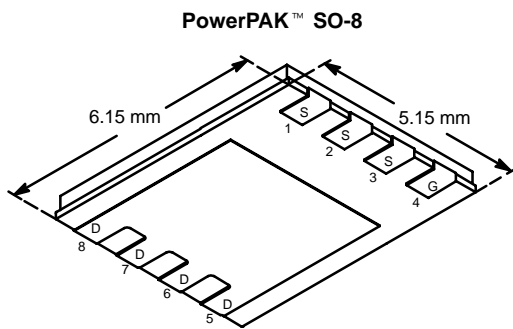
PRODUCT SUMMARY		
V_{DS} (V)	$r_{DS(on)}$ (Ω)	I_D (A)
200	0.130 @ $V_{GS} = 10$ V	4.1
	0.142 @ $V_{GS} = 6.0$ V	3.9

FEATURES

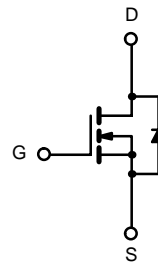
- TrenchFET® Power MOSFETS
- New Low Thermal Resistance PowerPAK™ Package with Low 1.07-mm Profile
- PWM Optimized For Fast Switching

APPLICATIONS

- Primary Side Switch



Bottom View
Ordering Information: Si7462DP-T1



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)					
Parameter	Symbol	10 secs	Steady State	Unit	
Drain-Source Voltage	V_{DS}	200		V	
Gate-Source Voltage	V_{GS}	± 20			
Continuous Drain Current ($T_J = 150^\circ\text{C}$) ^a	I_D	$T_A = 25^\circ\text{C}$	4.1	2.6	A
		$T_A = 85^\circ\text{C}$	3.0	1.9	
Pulsed Drain Current	I_{DM}	12			
Avalanche Current	I_{AS}	6			
Single Avalanche Energy (Duty Cycle $\leq 1\%$)	E_{AS}	L = 0.1 mH	1.8		mJ
Continuous Source Current (Diode Conduction) ^a			I_S	4.0	
Maximum Power Dissipation ^a	P_D	$T_A = 25^\circ\text{C}$	4.8	1.9	W
		$T_A = 85^\circ\text{C}$	2.6	1.0	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to 150		$^\circ\text{C}$	

THERMAL RESISTANCE RATINGS					
Parameter	Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^a	R_{thJA}	t ≤ 10 sec	21	26	$^\circ\text{C/W}$
		Steady State	55	65	
Maximum Junction-to-Case (Drain)	R_{thJC}	1.7	2.1		

Notes

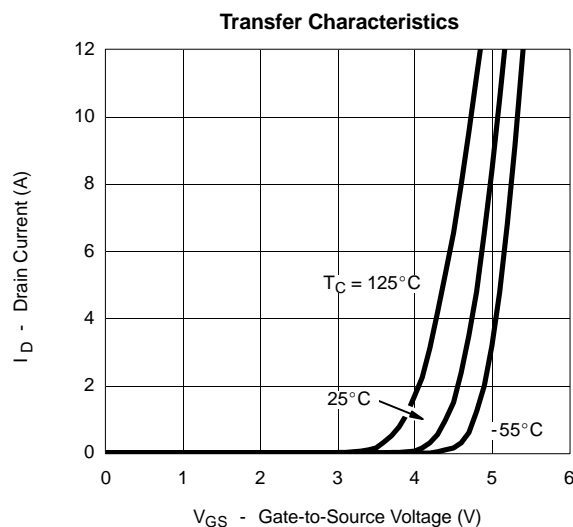
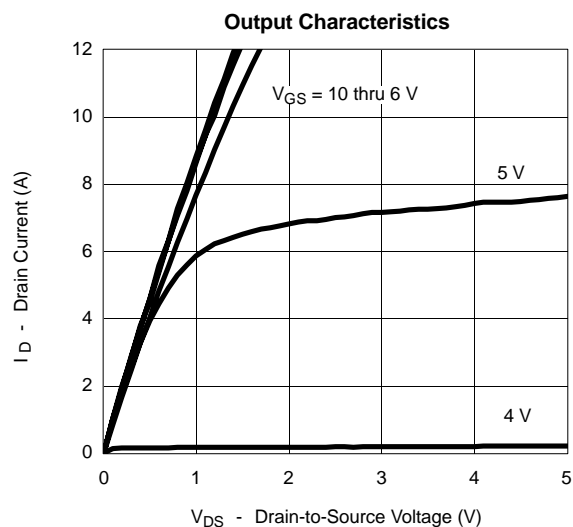
a. Surface Mounted on 1" x 1" FR4 Board.

SPECIFICATIONS (T_J = 25 °C UNLESS OTHERWISE NOTED)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	2		4	V
Gate-Body Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±20 V			±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 160 V, V _{GS} = 0 V			1	μA
		V _{DS} = 160 V, V _{GS} = 0 V, T _J = 85 °C			20	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	12			A
Drain-Source On-State Resistance ^a	r _{DS(on)}	V _{GS} = 10 V, I _D = 4.1 A		0.110	0.130	Ω
		V _{GS} = 6.0 V, I _D = 3.9 A		0.120	0.142	
Forward Transconductance ^a	g _{fs}	V _{DS} = 15 V, I _D = 4.1 A		13		S
Diode Forward Voltage ^a	V _{SD}	I _S = 4 A, V _{GS} = 0 V		0.8	1.2	V
Dynamic^b						
Total Gate Charge	Q _g	V _{DS} = 100 V, V _{GS} = 10 V, I _D = 4.1 A		20	30	nC
Gate-Source Charge	Q _{gs}		4.5			
Gate-Drain Charge	Q _{gd}		6.5			
Gate Resistance	R _G			2		Ω
Turn-On Delay Time	t _{d(on)}	V _{DD} = 100 V, R _L = 100 Ω I _D ≅ 1 A, V _{GEN} = 10 V, R _G = 6 Ω		15	25	ns
Rise Time	t _r		15	25		
Turn-Off Delay Time	t _{d(off)}		40	60		
Fall Time	t _f		20	30		
Source-Drain Reverse Recovery Time	t _{rr}	I _F = 4 A, di/dt = 100 A/μs		70	110	

Notes

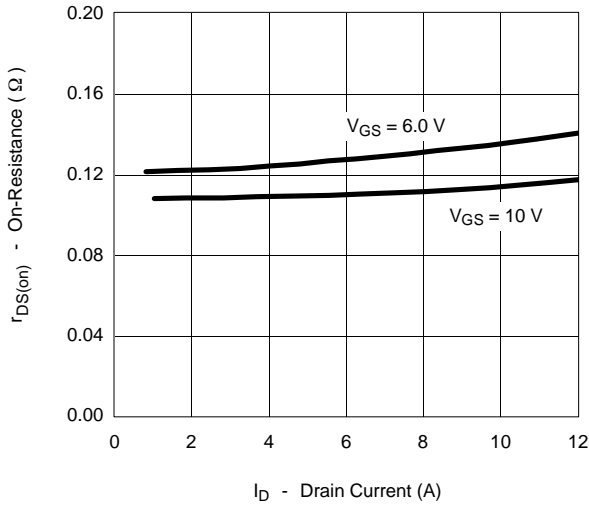
- a. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2%.
b. Guaranteed by design, not subject to production testing.

TYPICAL CHARACTERISTICS (25 °C UNLESS NOTED)

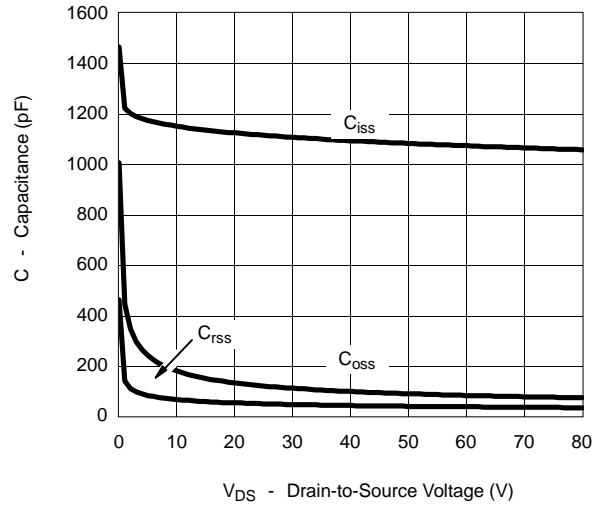


TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

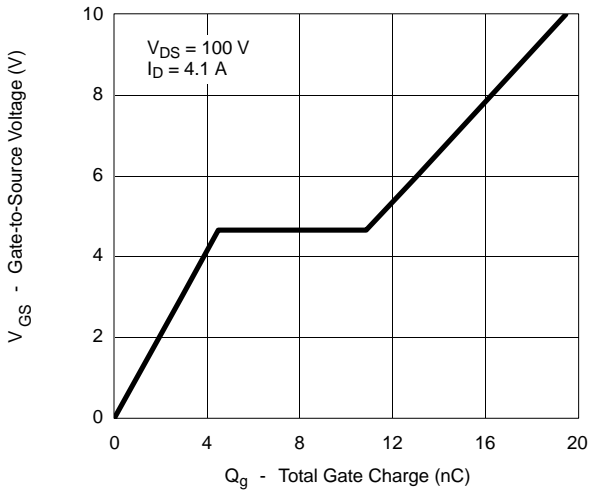
On-Resistance vs. Drain Current



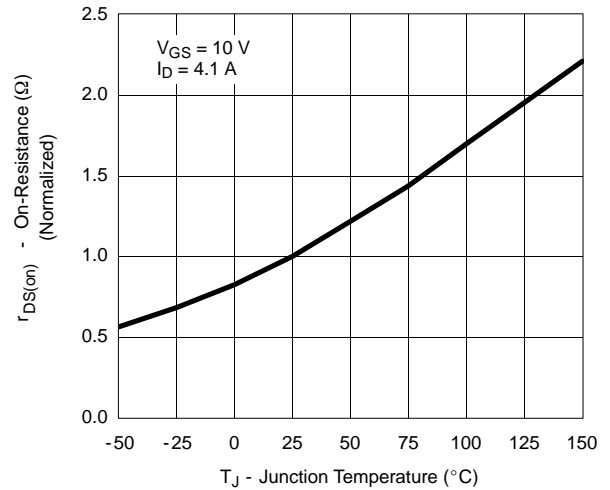
Capacitance



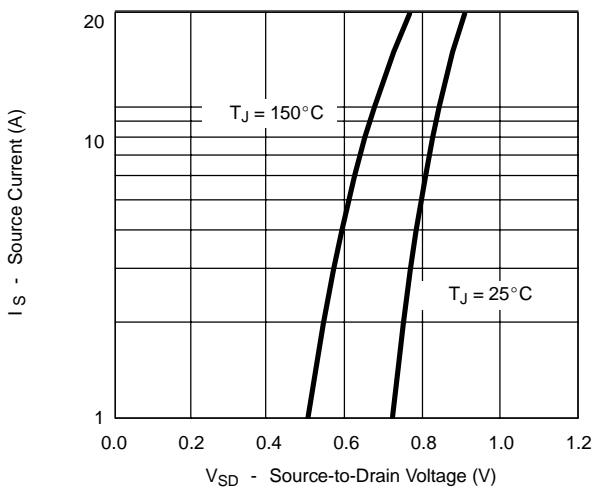
Gate Charge



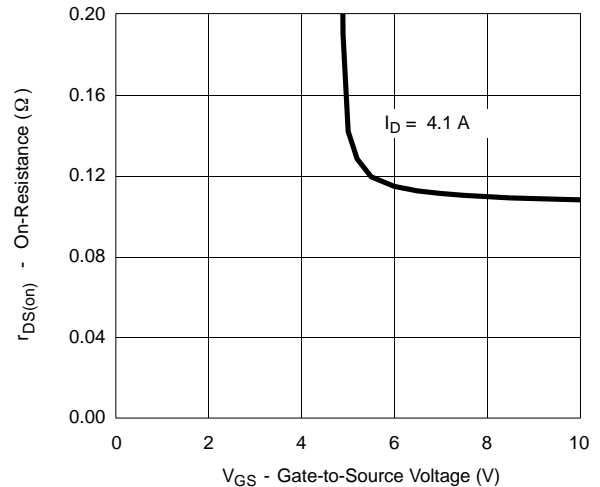
On-Resistance vs. Junction Temperature



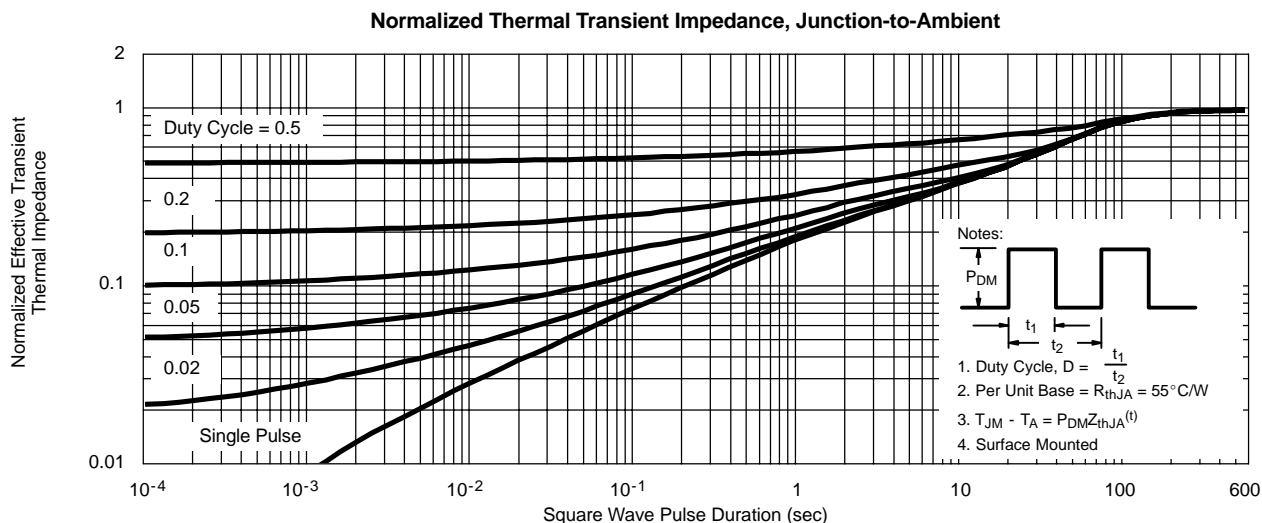
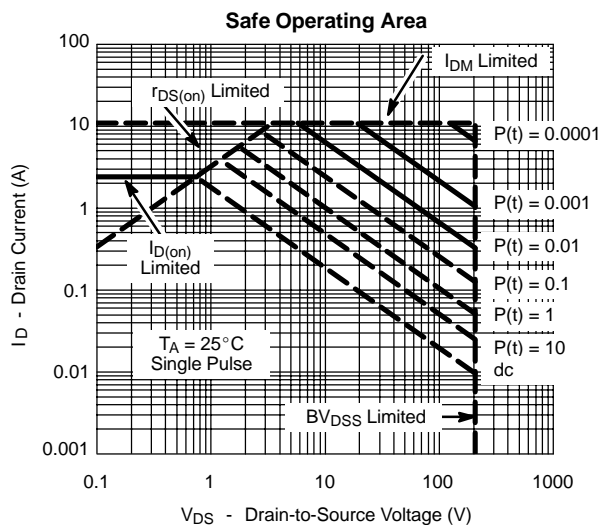
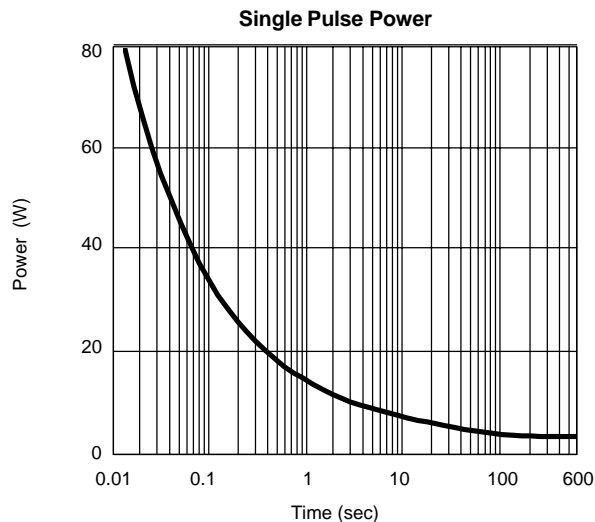
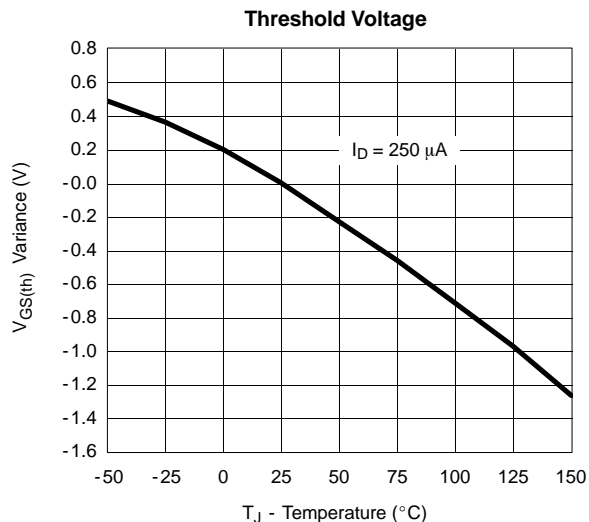
Source-Drain Diode Forward Voltage



On-Resistance vs. Gate-to-Source Voltage



TYPICAL CHARACTERISTICS (25 °C UNLESS NOTED)





TYPICAL CHARACTERISTICS (25 °C UNLESS NOTED)

Normalized Thermal Transient Impedance, Junction-to-Case

